Se	arch	Notes	

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/518,087	INOUE, FUJIO	
Examiner	Art Unit	
Chen-Wen Jiang	3744	

SEARCHED					
Class	Subclass	Date	Examiner		
236	101R 93R 101C 34 34.5				
137	467				
123	41.08				
	41.09 41.1	8/29/2007	Cl		
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
EAST Searched Inventor Searched	8/29/2007	ĊJ	
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